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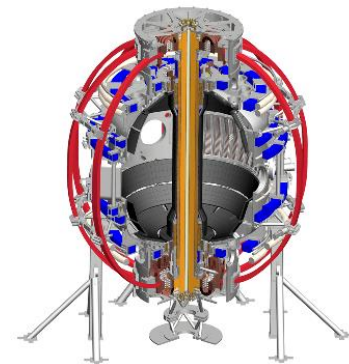
Preparation for a Beam Ion Confinement Experiment on NSTX-U

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M. Podestà, D.S. Darrow, E. Fredrickson, S. S. Medley (PPPL)

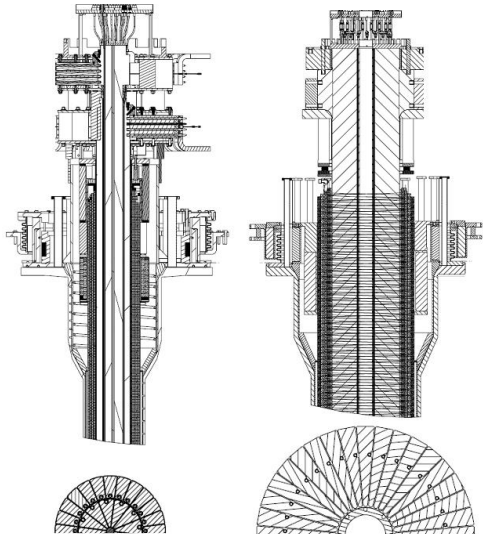
57th Annual Meeting of the APS Division of Plasma Physics
Savannah, GA
November 16-20, 2015

UCIrvine
University of California, Irvine



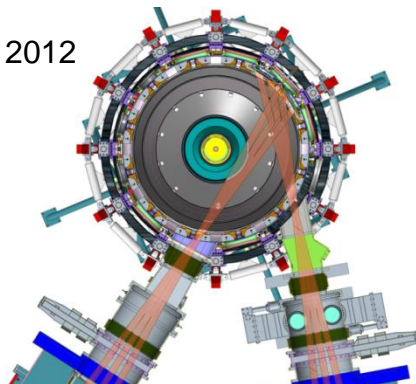
The National Spherical Torus Experiment Upgrade (NSTX-U) will Enable New Fast Ion Physics Study

Previous center-stack **New center-stack**



TF OD = 20cm **TF OD = 40cm**

J. Menard
Nucl. Fusion 2012



Present NBI | **New 2nd NBI**

- New center column will double toroidal magnetic field and plasma current
 - Prompt loss of existing NBI is expected to decrease because of smaller gyro-radius and higher current
- Second neutral beam injection (NBI) system will double heating power and increases flexibility and neutral beam driven current efficiency
 - Fast ion profile can be varied from peaked profile to relatively broad profile, thus changing fast ion driven instabilities
 - Good fast-ion confinement is essential to achieve the anticipated improvements in performance
- A “sanity check” experiment is planned to characterize the fast ion confinement and fast ion distribution produced by the new and existing NBI.

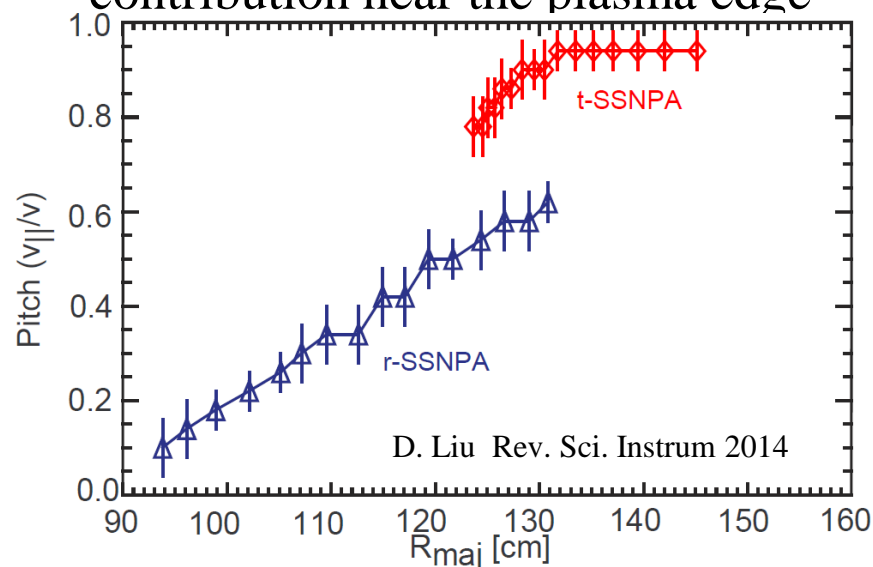
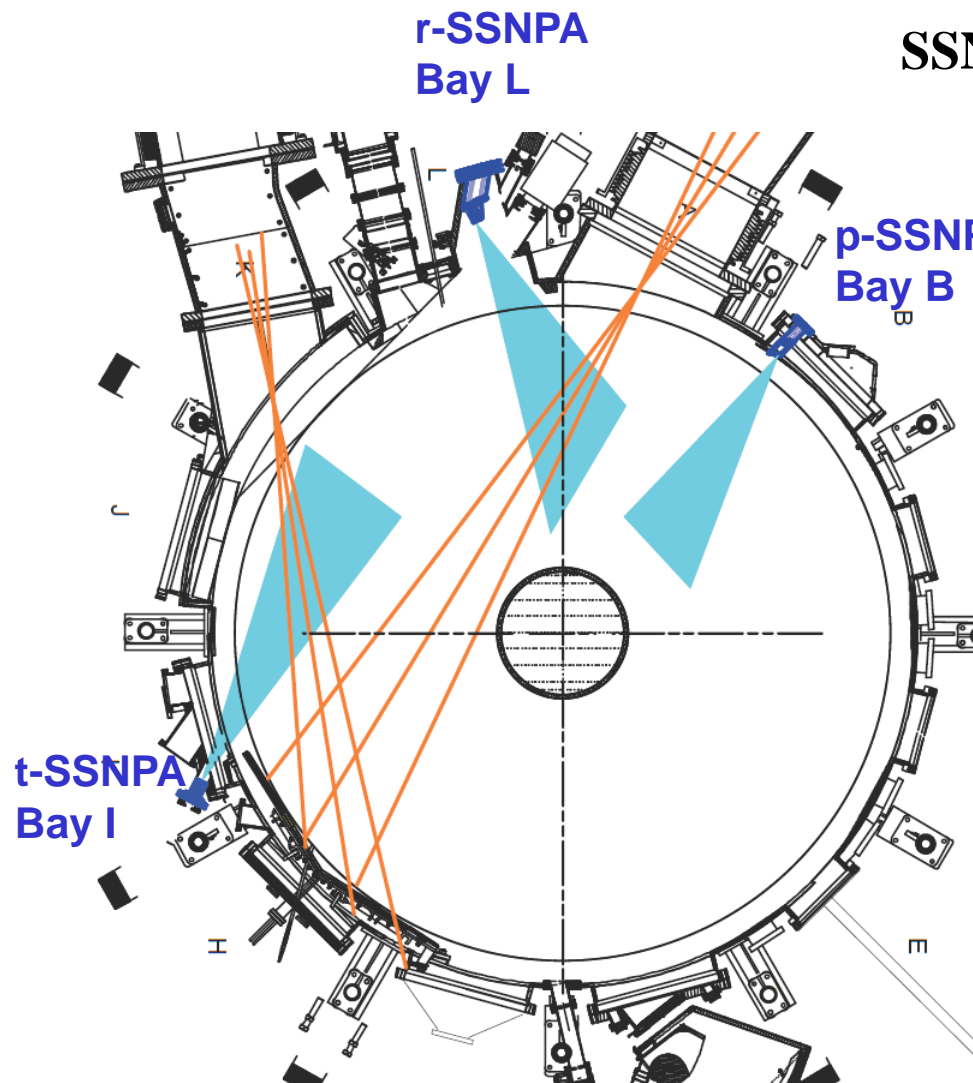
A Comprehensive Set of Fast Ion Diagnostics on NSTX-U

- Neutron detectors
dominated by beam-plasma reactions, volume integrated
- Fast-Ion D-alpha (FIDA) spectrometers
sensitive to a swath in velocity space, spatial profile
- Solid State Neutral Particle Analyzer (SSNPA) array
very localized in pitch angle range, spatial profile, fast time resolution
- Scintillator-based Fast Loss Ion Probe (sFLIP)
lost fast ions, narrow in pitch angle
- Fusion product profile array
strongly weighted toward high energy fast ions

New SSNPA System Views a Large Range of Plasma & Distinguishes Response from Passing & Trapped Fast Ions

SSNPA measures charge exchange fast ions

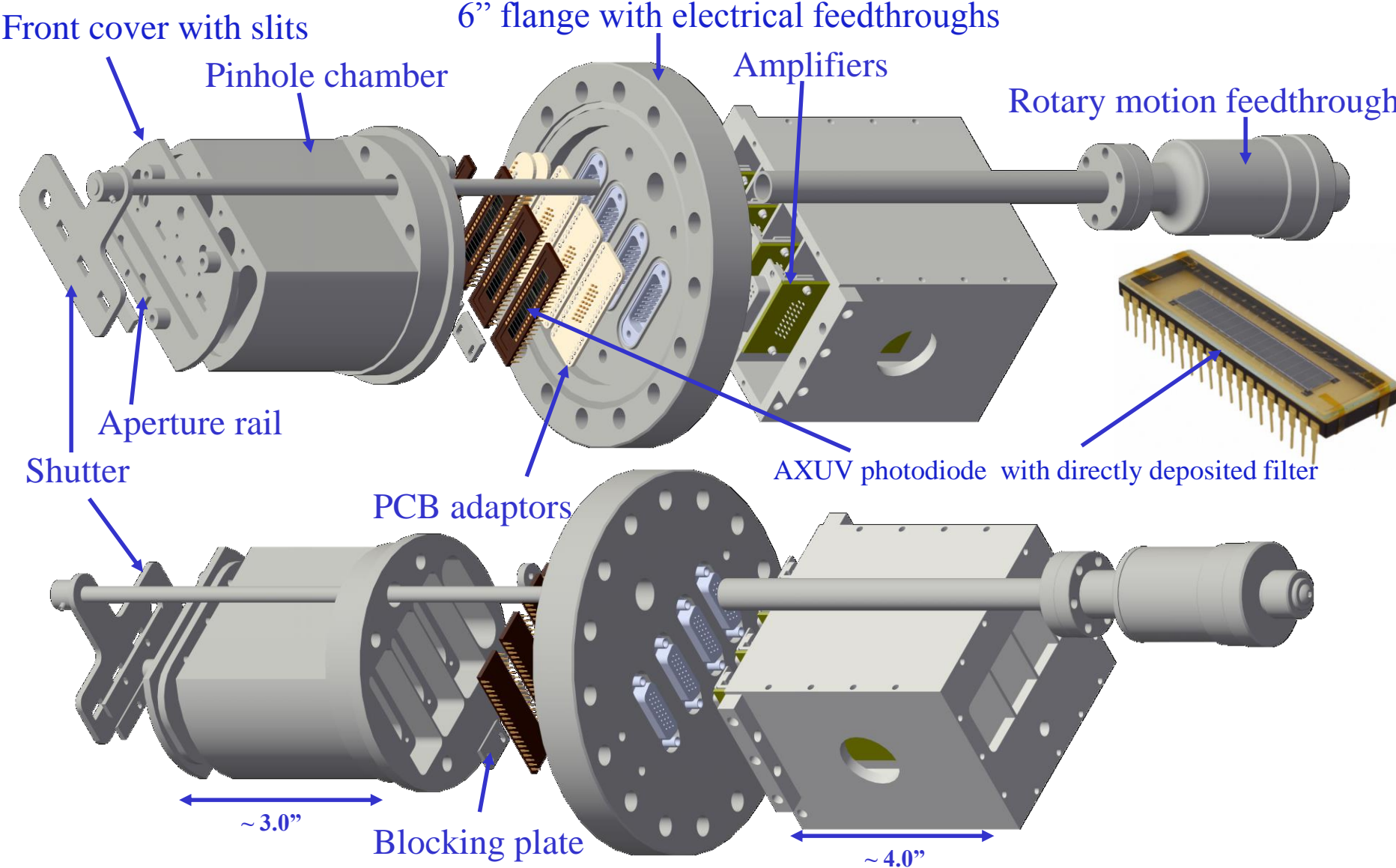
- **t-SSNPA at Bay I**
16 tangential views; passing fast ions
- **r-SSNPA at Bay L**
16 radial views; trapped fast ions
- **p-SSNPA at Bay B**
16 reference views; monitor passive contribution near the plasma edge



Design Criteria of SSNPA System

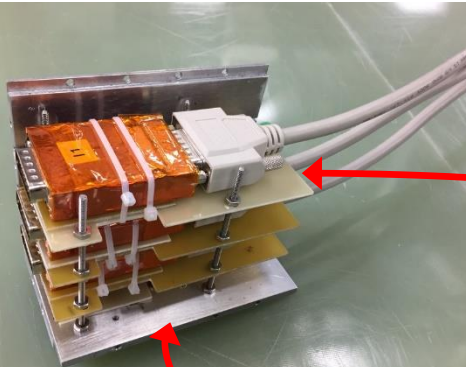
- Reentrant at Bay L and Bay B for desired field of view
- Stacked arrays with different foil thickness for coarse energy resolution
- Noise minimization
 - Amplifier is very close to detectors.
 - “Blind” detector monitors EM noise.
 - Low pass filter suppresses high frequency noise.
- Shutter protects detectors during glow discharges and lithium dropping experiments.
- Active cooling to protect detectors during bake out.

One Example: Expanded View of t-SSNPA Subsystem at Bay I



New SSNPA System is Ready for Plasma Operation

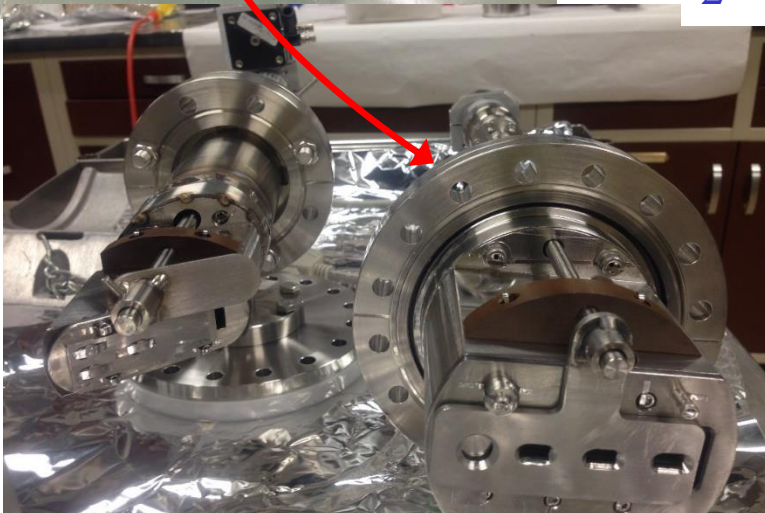
Transimpedance amplifiers



2nd stage amplifier



Power supply and gain control



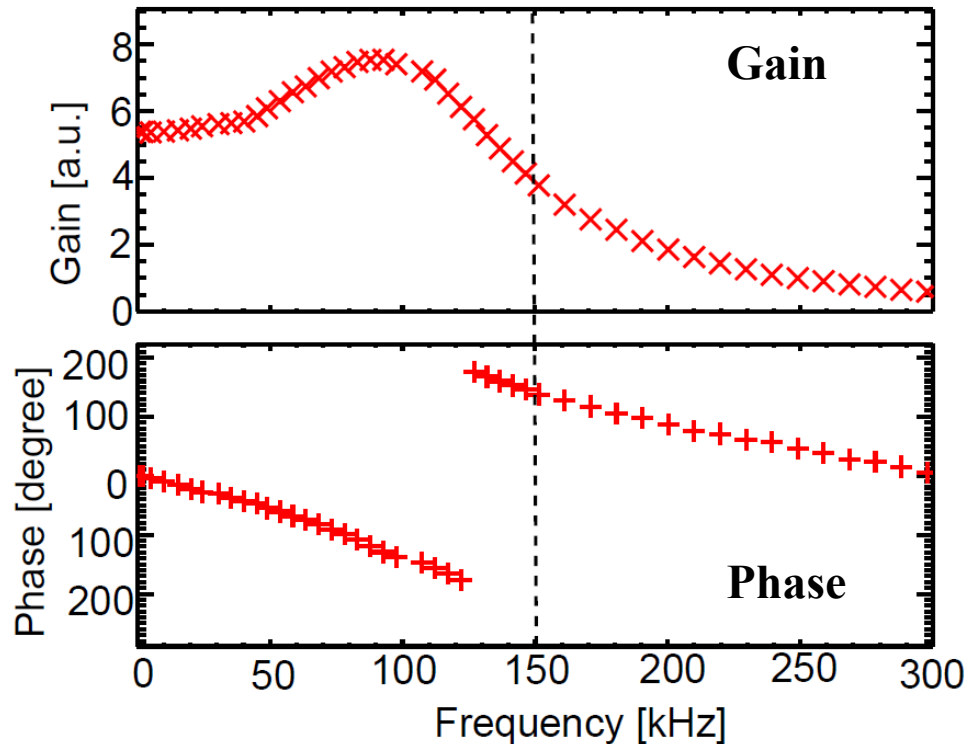
Vacuum interfaces with detectors installed



D-tacq digitizer

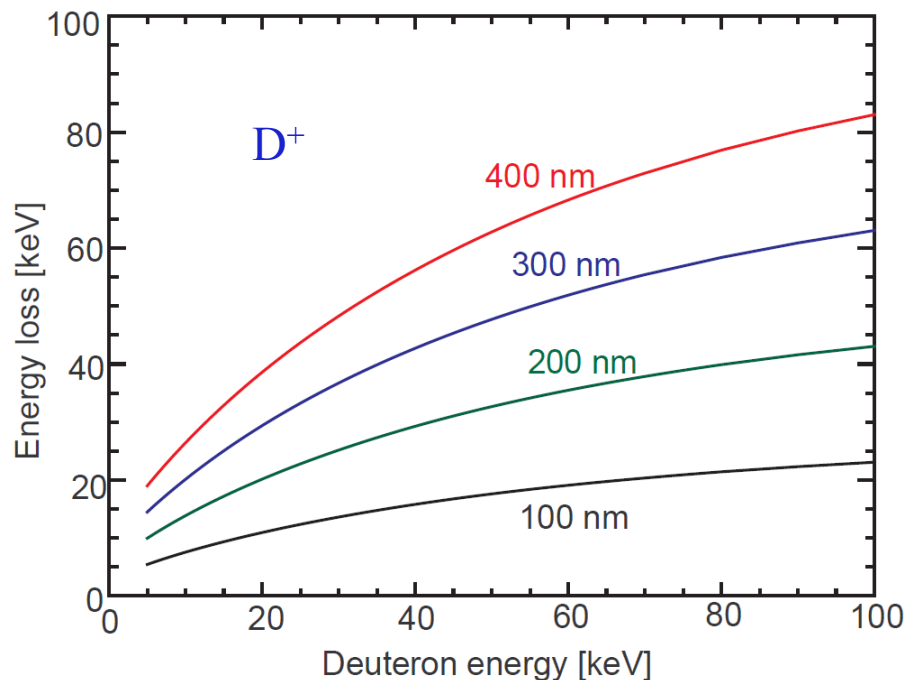
- Vacuum interfaces and detectors are installed
- Electronics have been tested on bench
- Data acquisition system is being tested.

New SSNPA System Aims at Measuring Fast Ion Density Fluctuation up to 150 kHz

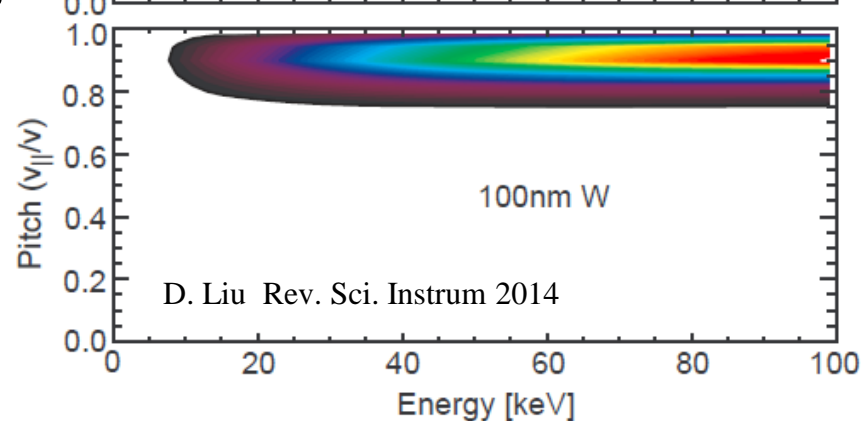
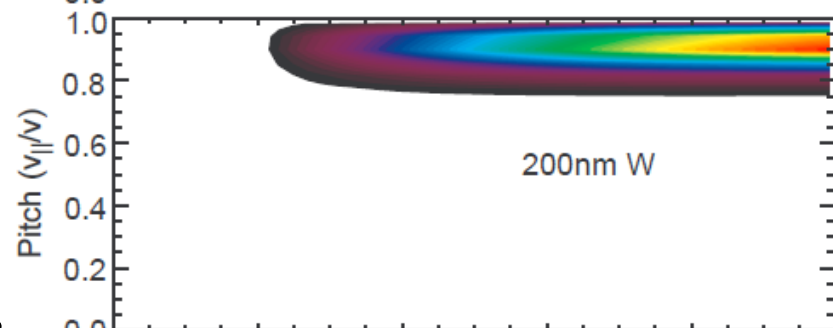
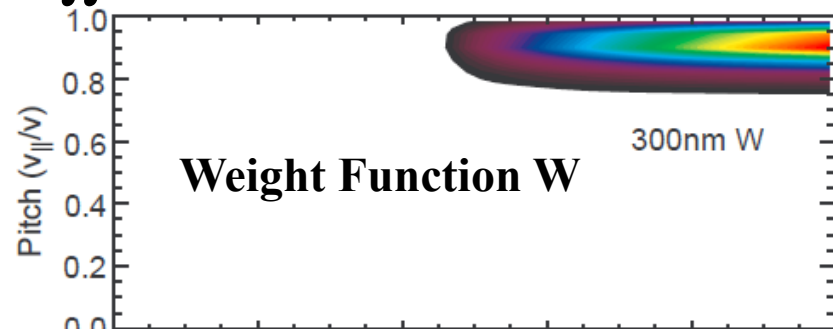


- Bandwidth of amplifier is $\sim 150\text{kHz}$ at gain of $5 \times 10^5 \text{V/A}$
- Low-pass filters suppress high frequency noise.
- Low noise ($< 5\text{mV}$) during on-bench tests.

New SSNPA System will also Obtain Coarse Energy Information



$$S = \iint WF_f dEdP \quad F_f: \text{fast ion distribution function}$$



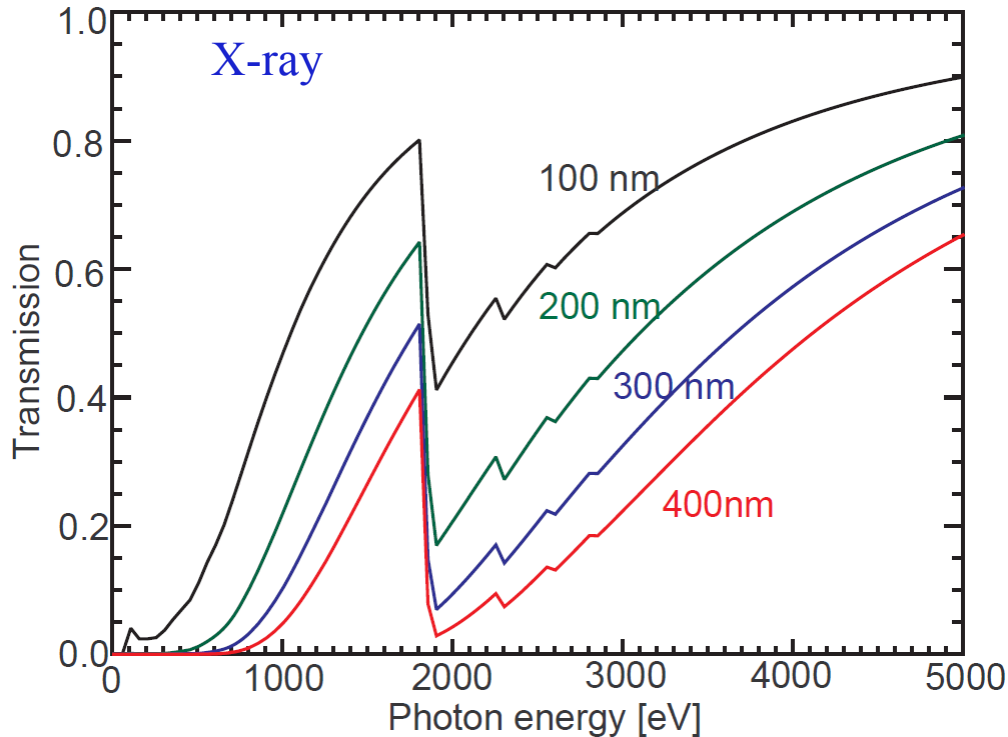
D. Liu Rev. Sci. Instrum 2014

➤ Thickness of directly deposited filter sets cut-off energy

Foil thickness Energy loss for 100 keV D^+

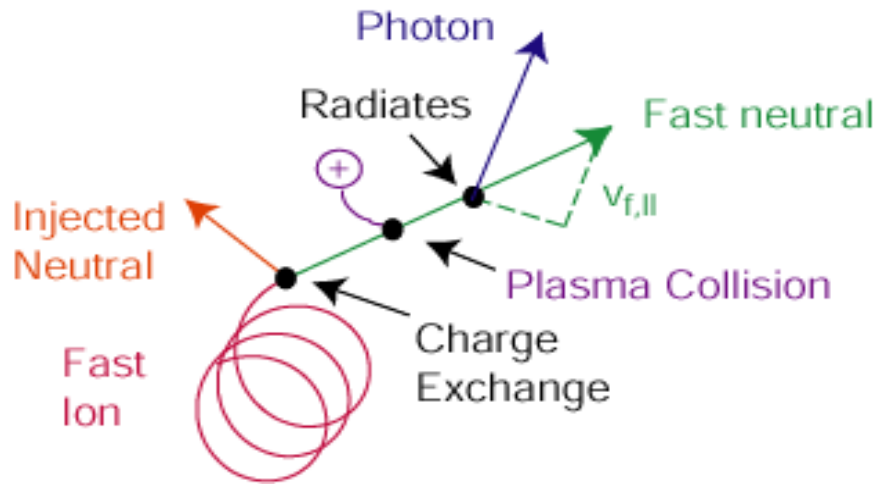
- 100nm ~25keV
- 200nm ~45keV
- 300nm ~65keV

Directly Deposited Filters Block Stray Photons



- Directly deposited filters are more robust and reliable than free-standing foils
- High Z filter is directly deposited on detectors to block visible light and soft x-ray

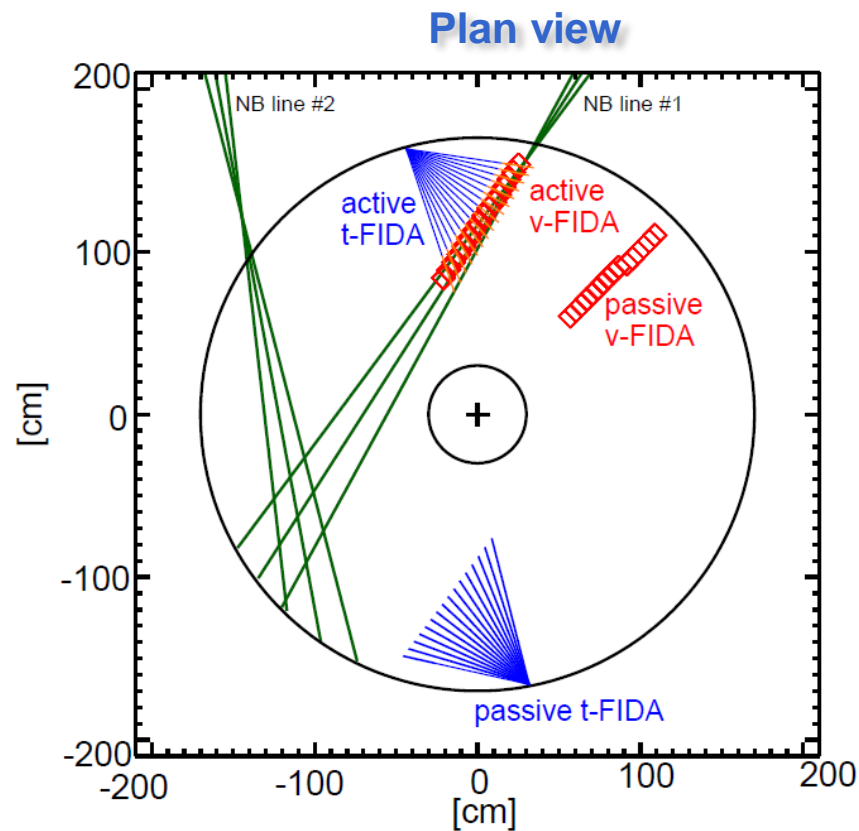
FIDA is an Application of Charge Exchange Recombination Spectroscopy



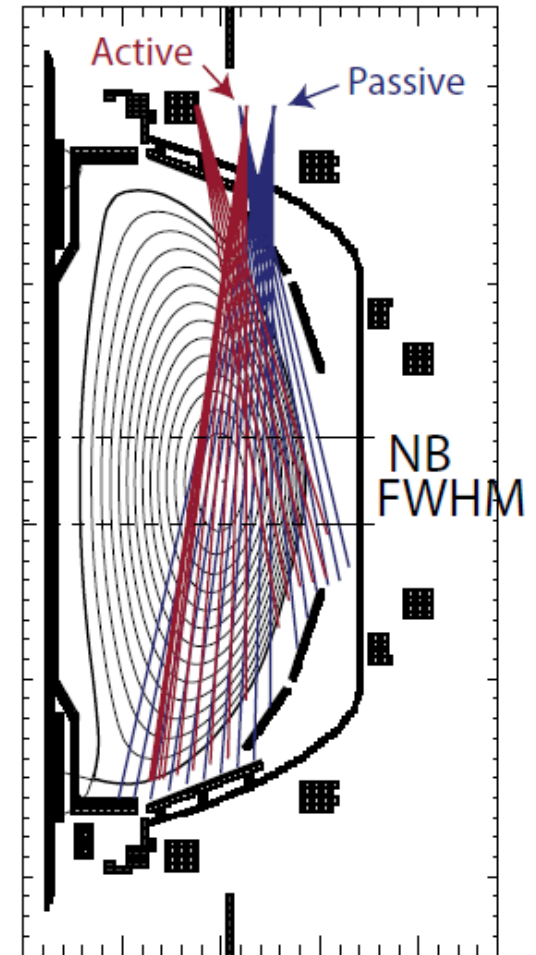
W. W. Heidbrink, Rev. Sci. Instrum. **81**
(2010) 10D727

- The fast ion exchanges an electron with an injected neutral
- Neutrals in the $n=3$ state relax to an equilibrium population; some radiate
- The Doppler shift of the emitted photon depends on a component of the fast-ion velocity

Two Sets of FIDA Diagnostics on NSTX-U



Elevation of v-FIDA



- **Vertical and tangential FIDA Diagnostics consist of two sub-systems**

- spectrometer-FIDA, full D_{α} spectrum , 16 channels

- $R=0.86-1.66m$, 100Hz

- band-pass filter-FIDA, 3 channels at $R=1.0, 1.2, 1.4m$, 50kHz

V-FIDA: M. Podesta, Rev. Sci. Instrum 2008
 T-FIDA: A. Bortolon, Rev. Sci. Instrum 2010

v-FIDA and T-FIDA Systems Separate the Response of Trapped and Passing Fast Ions

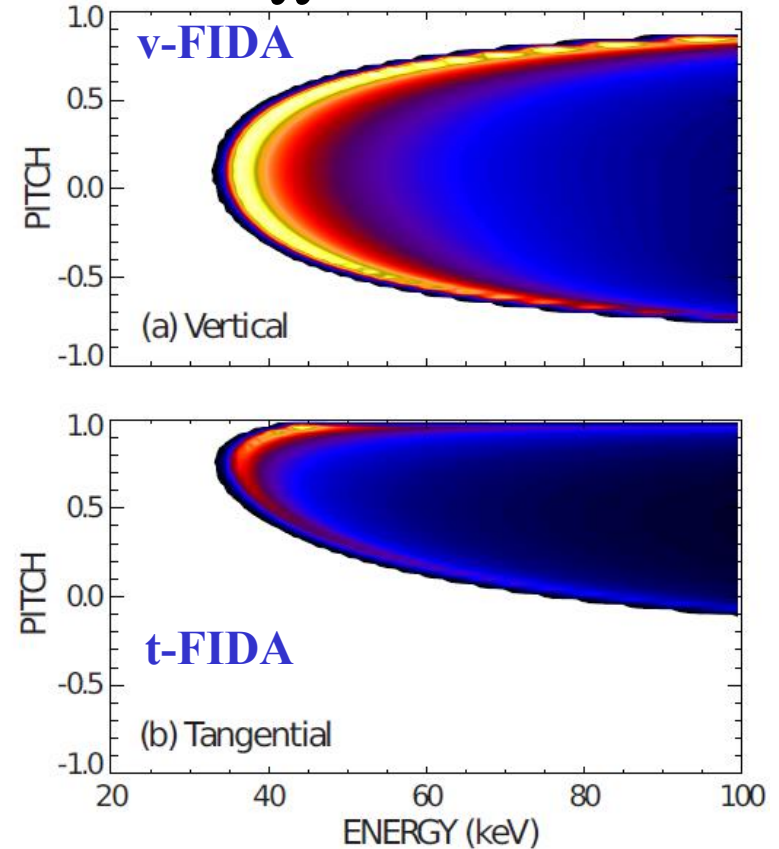
Vertical FIDA

- most sensitive to trapped particles

Tangential FIDA

- most sensitive to passing particles

$$S = \iint WF_f dEdP$$

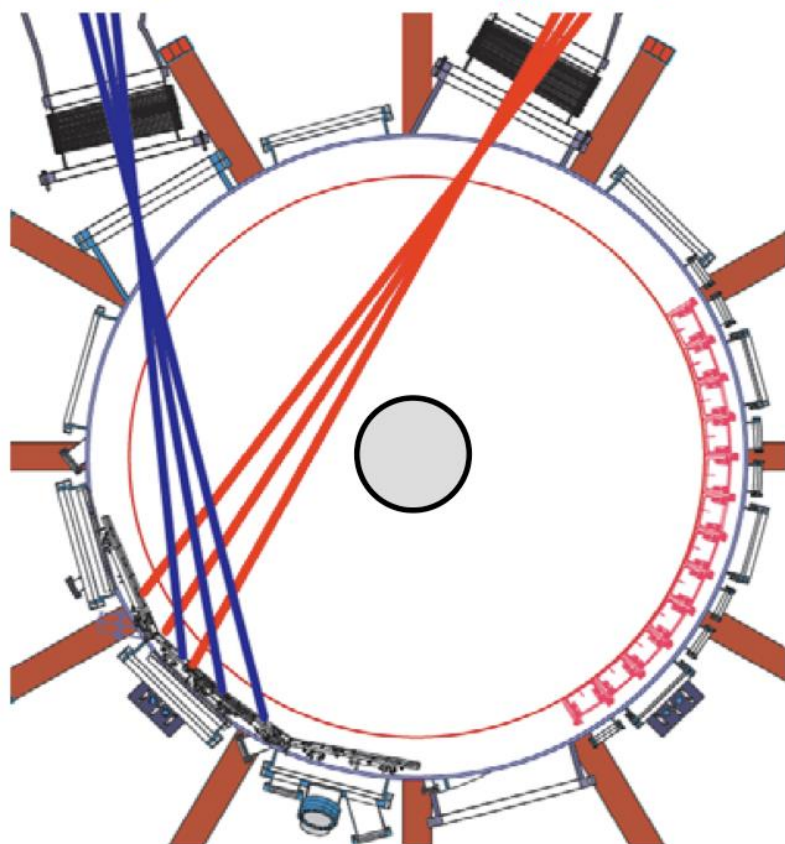


A. Bortolon, Rev. Sci. Instrum 2010

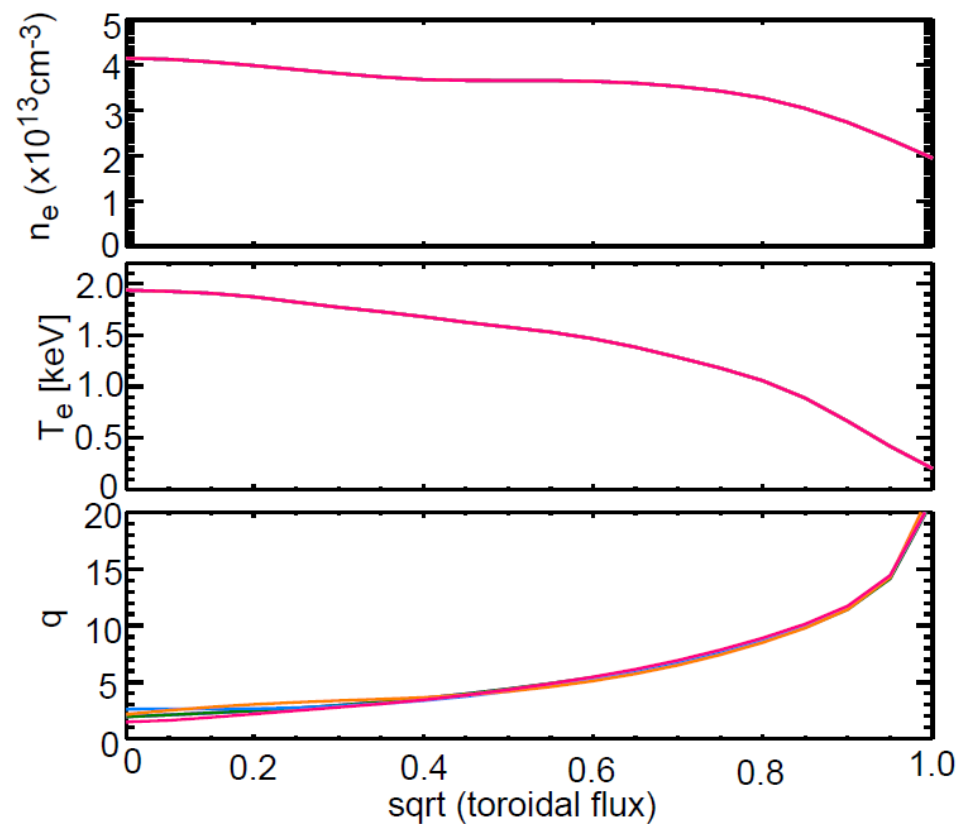
Fast Ion Distribution from NBI Line #1 and #2 is Simulated with TRANSP

New 2nd NBI
 $R_{TAN}=110,120,130\text{cm}$

Present NBI
 $R_{TAN}=50,60,70\text{cm}$



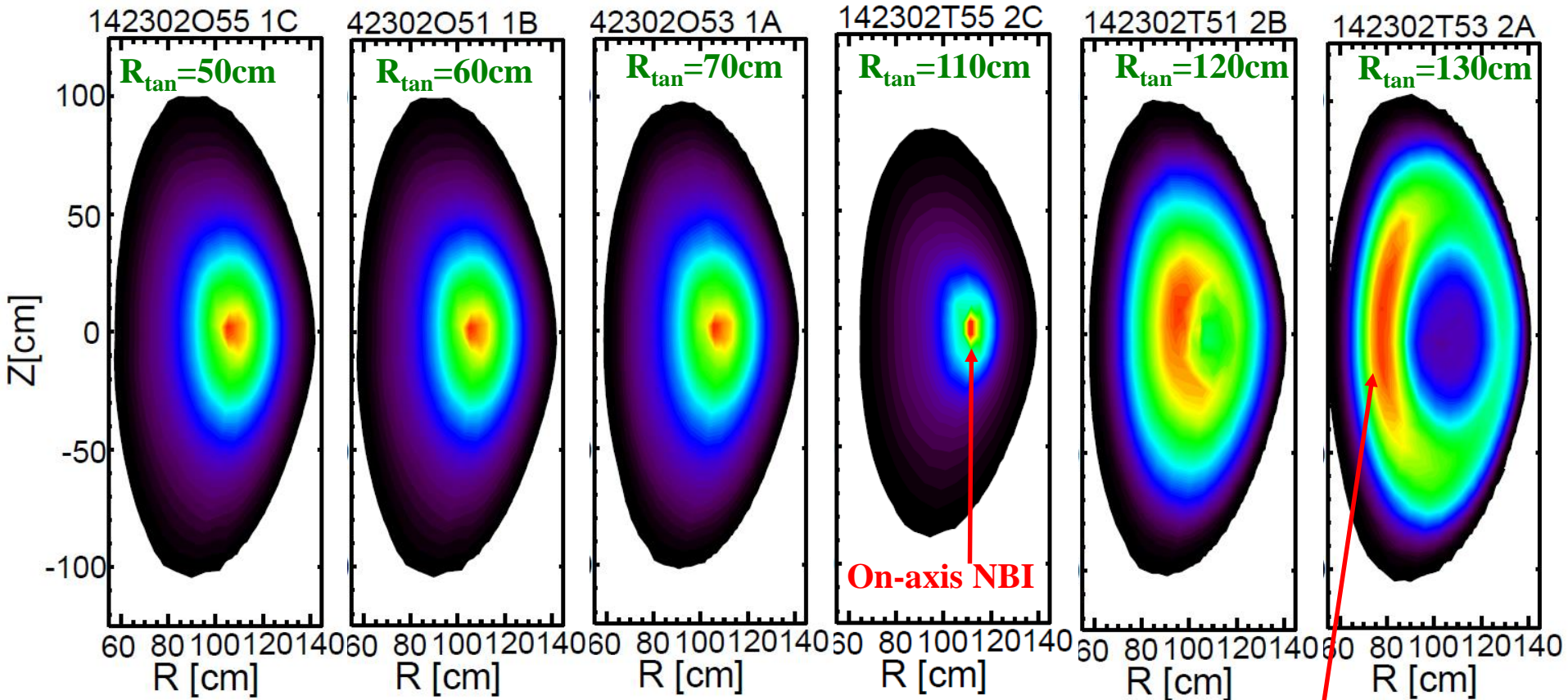
Input plasma profiles for TRANSP simulation



1C ($R_{tan}=50\text{cm}$), 1B ($R_{tan}=60\text{cm}$), 1A ($R_{tan}=70\text{cm}$)
2C ($R_{tan}=110\text{cm}$), 2B ($R_{tan}=120\text{cm}$), 2A ($R_{tan}=130\text{cm}$)

Fast Ion Density Profile Varies with Neutral Beam Source

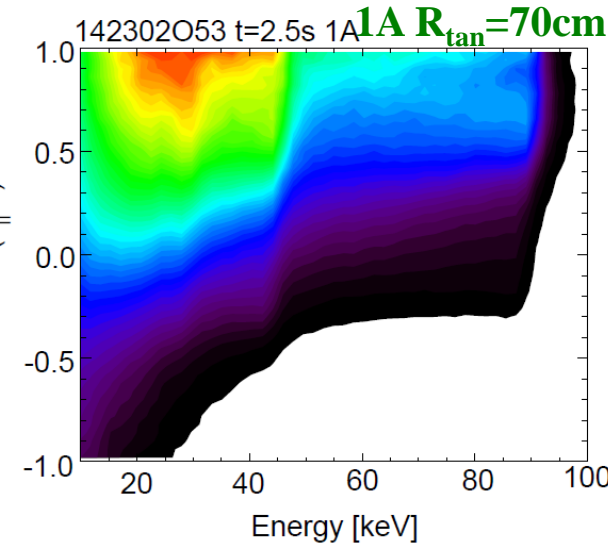
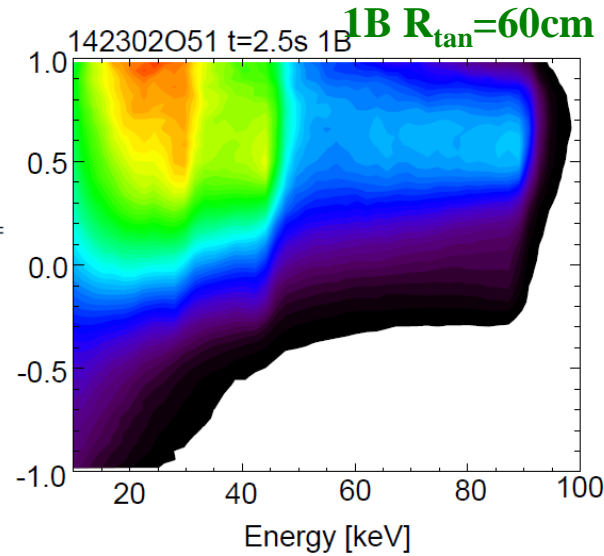
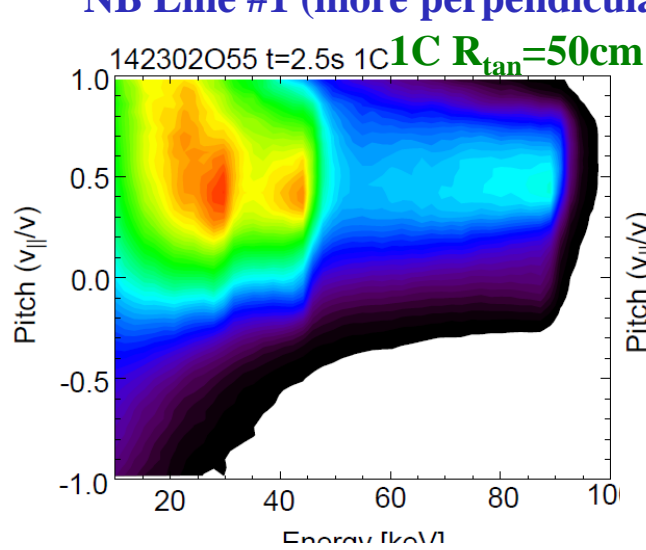
More perpendicular \rightarrow More Tangential



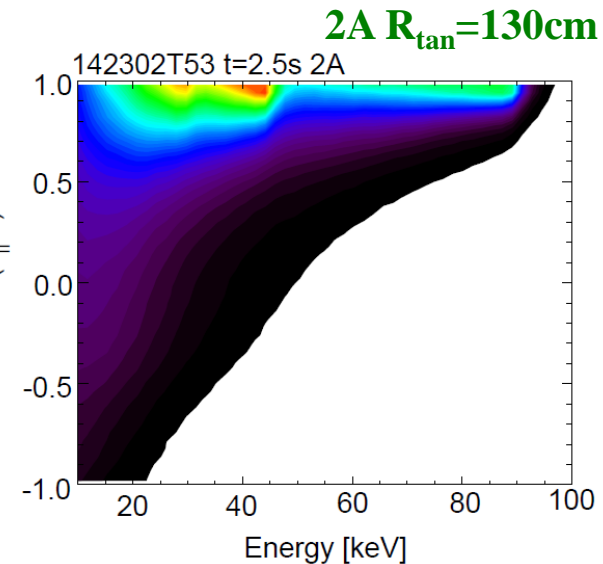
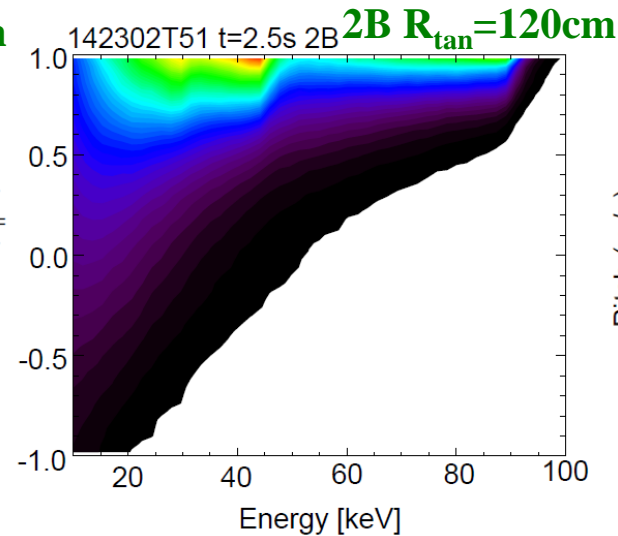
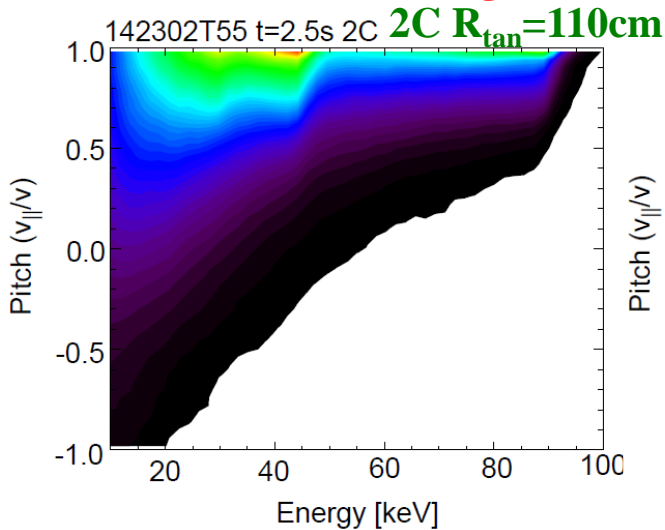
Passing fast ions spend more time at high field side due to small major radius

Fast Ion Pitch Angle Varies with Neutral Beam Source

NB Line #1 (more perpendicular)



NB Line #2 (more tangential)



Fast Ion Distribution in Constants-of-motion Space Varies with Neutral Beam Source

NB Line #1 (more perpendicular)

1C $R_{tan}=50cm$

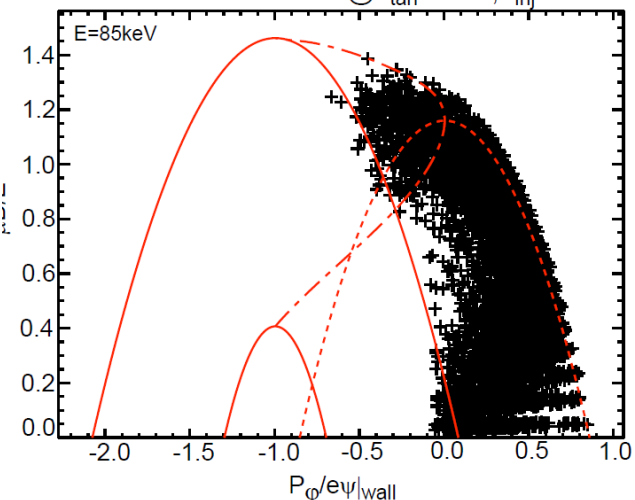
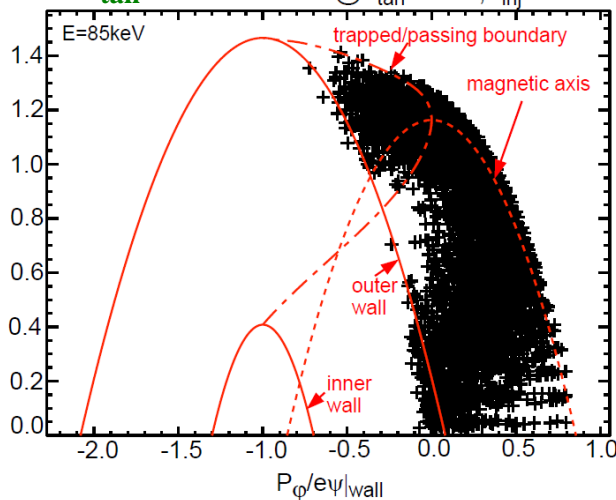
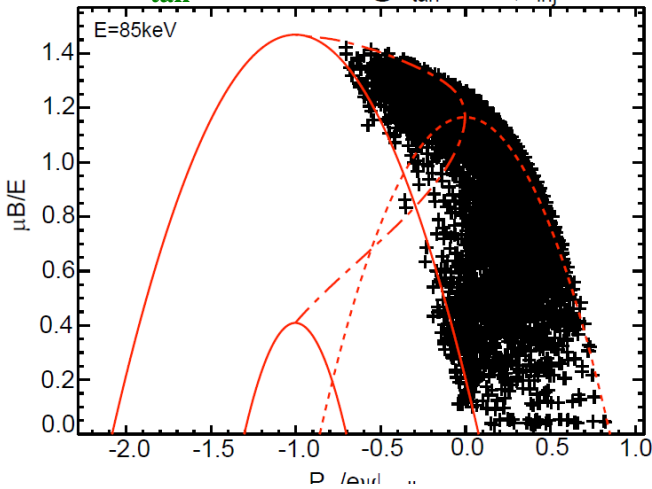
1C@ $R_{tan}=50cm, E_{inj}=90keV$

1B $R_{tan}=60cm$

1B@ $R_{tan}=60cm, E_{inj}=90keV$

1A $R_{tan}=70cm$

1A@ $R_{tan}=70cm, E_{inj}=90keV$



NB Line #2 (more tangential)

2C $R_{tan}=110cm$

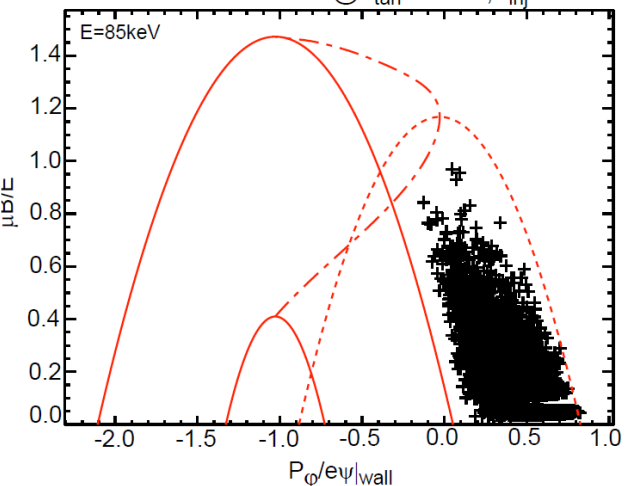
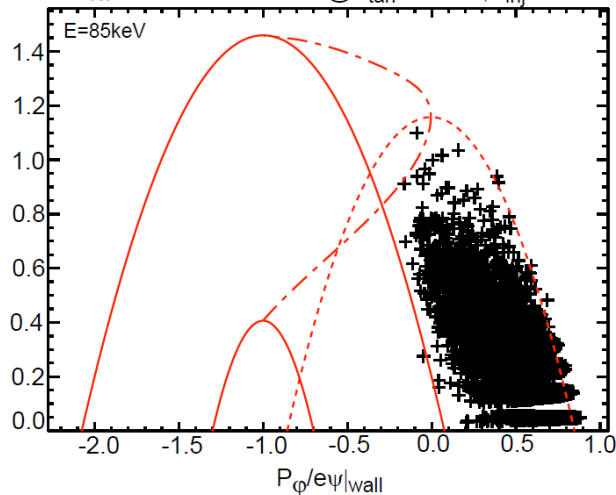
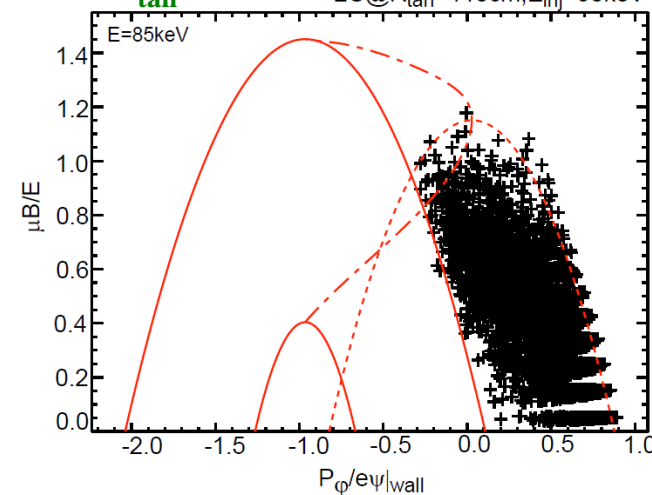
2C@ $R_{tan}=110cm, E_{inj}=90keV$

2B $R_{tan}=120cm$

2B@ $R_{tan}=120cm, E_{inj}=90keV$

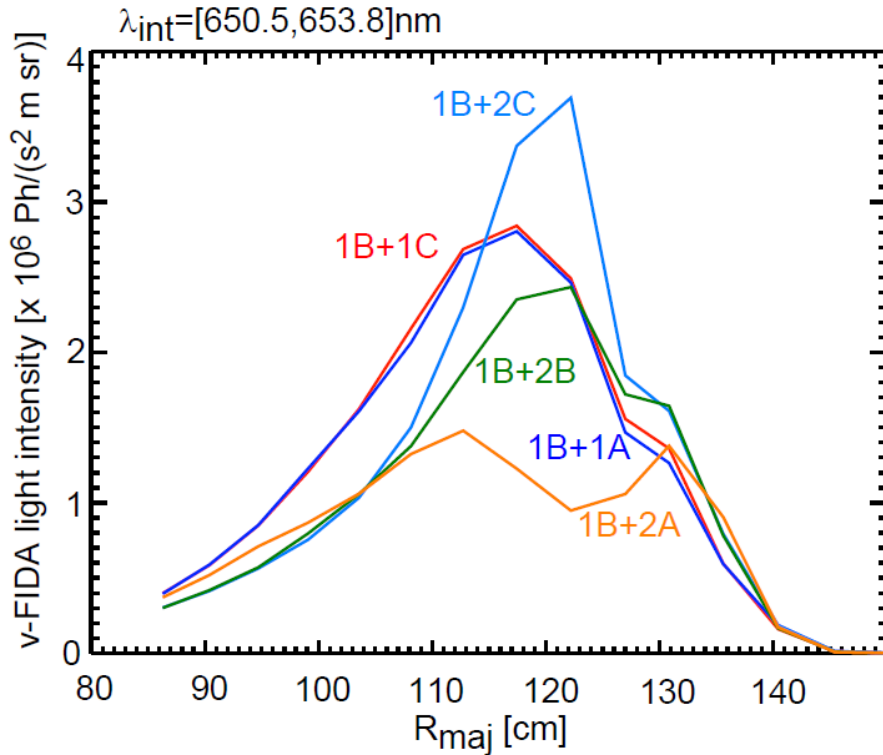
2A $R_{tan}=130cm$

2A@ $R_{tan}=130cm, E_{inj}=90keV$

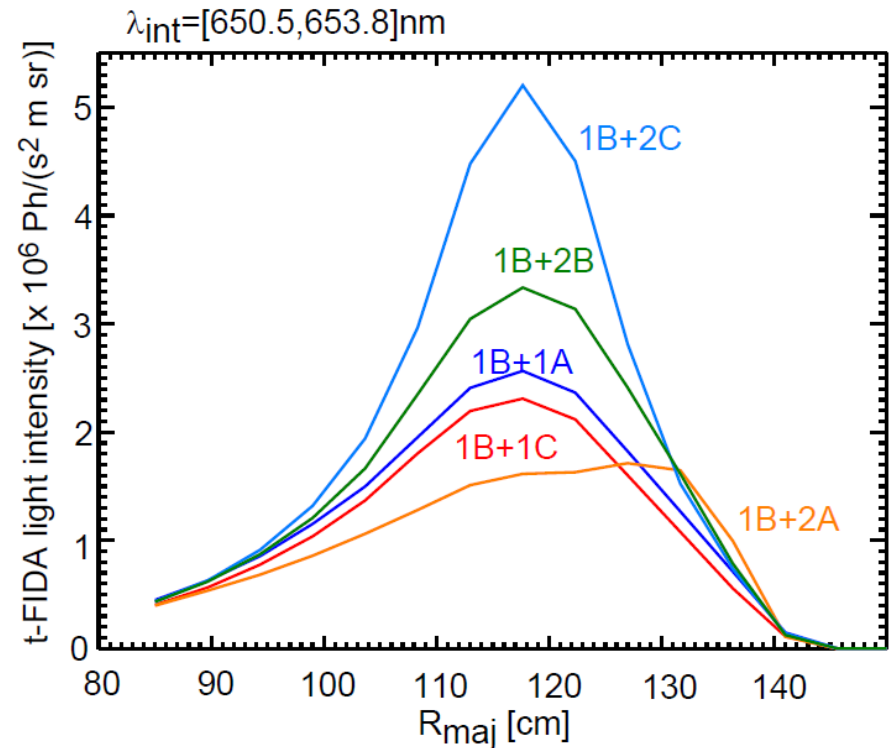


FIDA Spatial Profile/Magnitude is Expected to Vary with Different Neutral Beam Source

v-FIDA (most sensitive to trapped particles)



t-FIDA (most sensitive to passing particles)



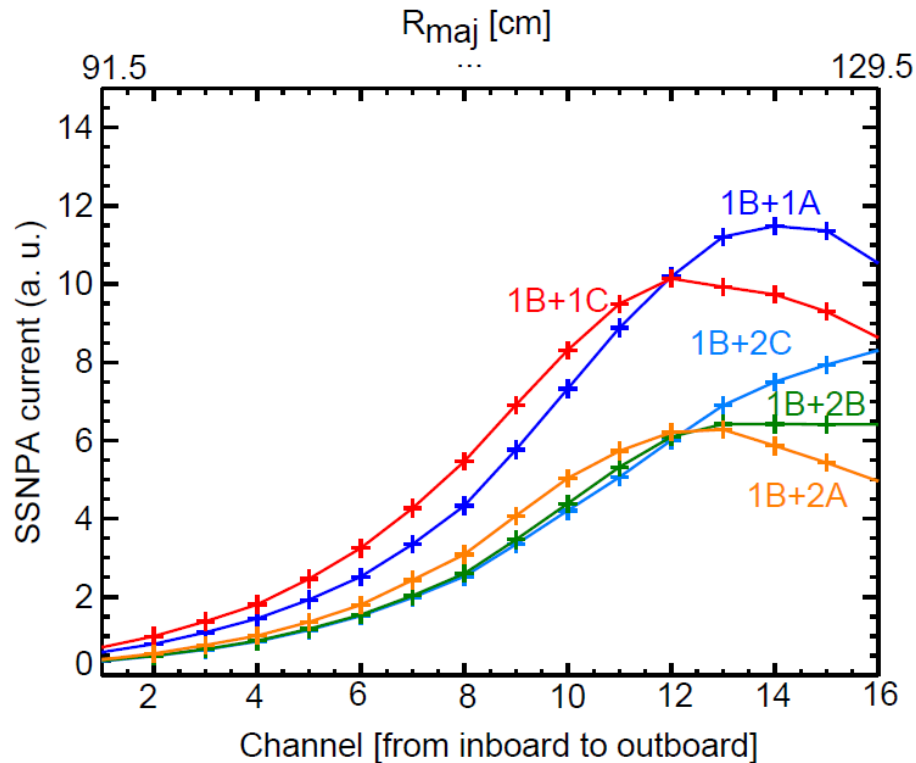
When switching from the existing NBI line to new NBI line,

- Significant magnitude difference is expected for both v-FIDA and t-FIDA systems.
- Significant profile difference is expected for v-FIDA

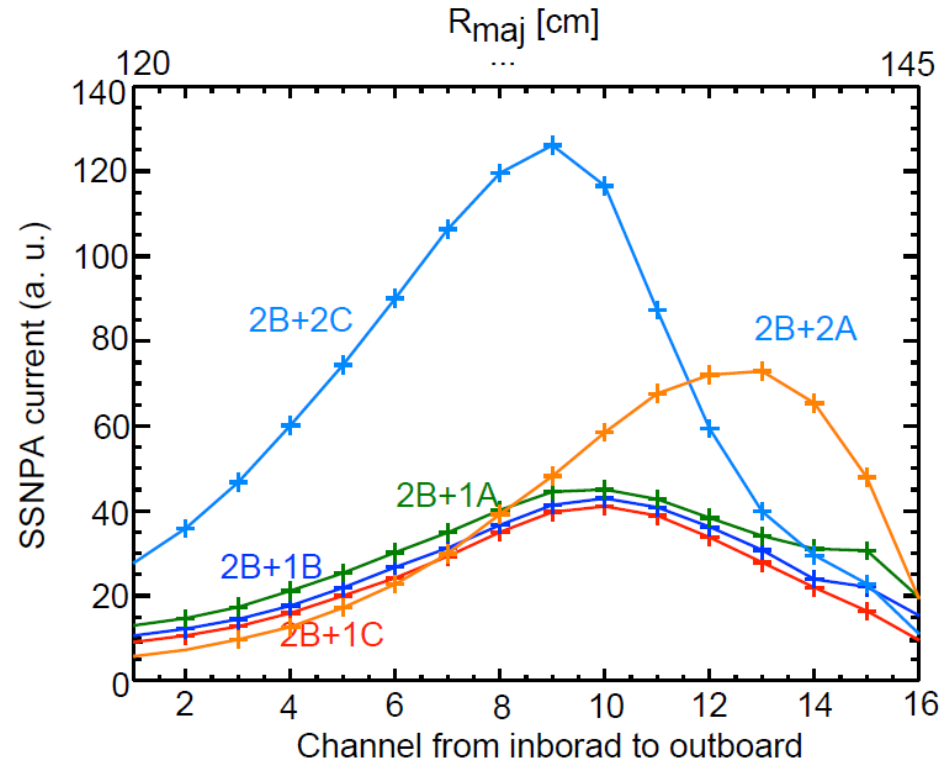
Note: NB source 1B provides beam neutrals for FIDA systems.

SSNPA Profile is Expected to be Different When Switching from Neutral Beam Line #1 to #2

r-SSNPA (mostly sensitive to trapped particles)



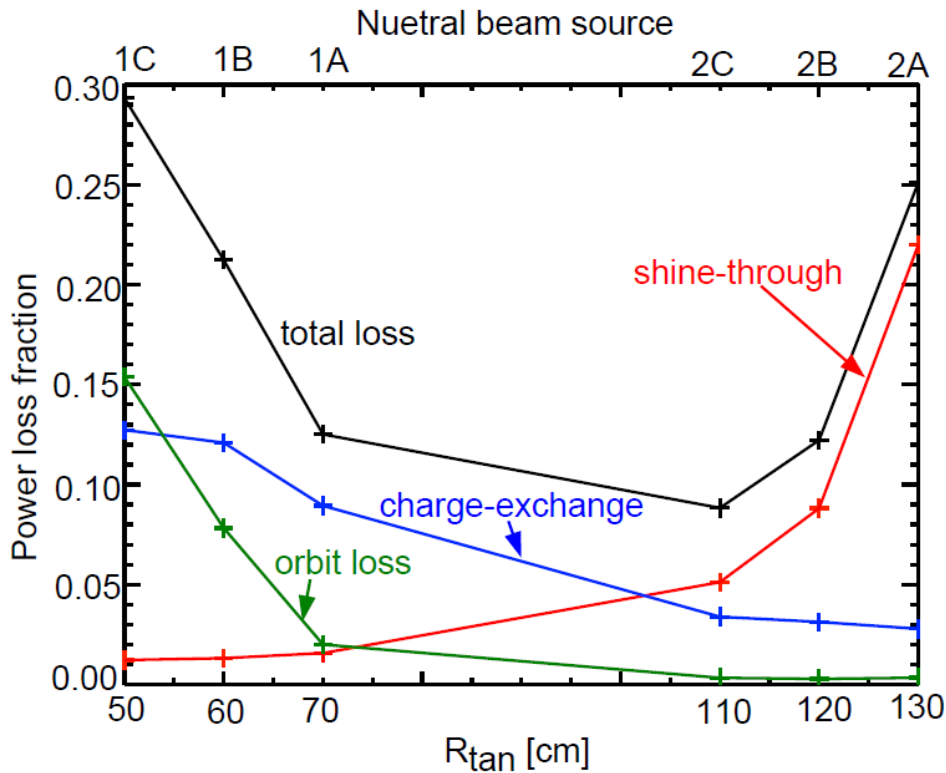
t-SSNPA (mostly sensitive to passing particles)



When switching from the existing NBI line to new NBI line,

- Significant magnitude difference is expected for both r-SSNPA and t-SSNPA systems.
- Significant profile difference is expected for t-SSNPA

Shine-through Loss Dominates for the New NBI



Existing NBI ($R_{tan}=50,60,70$ cm)

1C: mainly prompt loss

1B and 1A: charge-exchange loss

New NBI ($R_{tan}=110,120,130$ cm)

2C/2B/2A: shine-through loss

Plan of Beam Ion Confinement Experiment

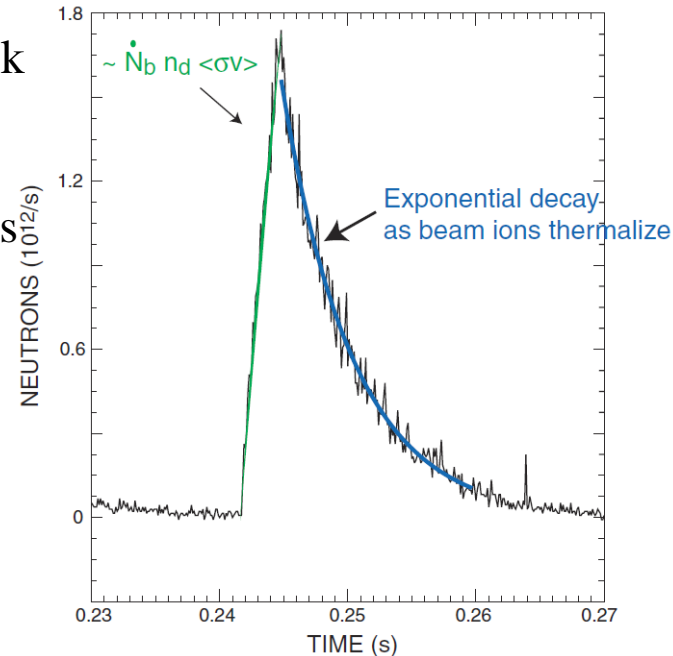
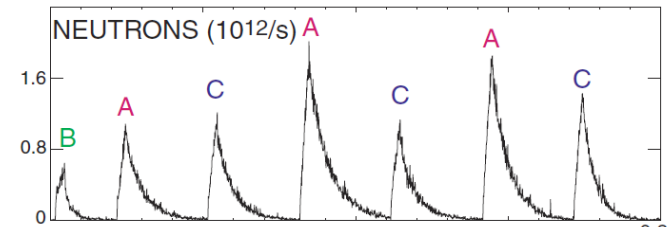
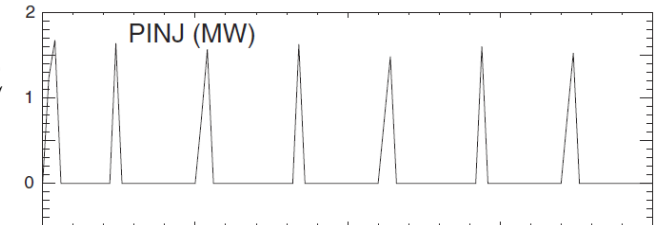
Objective

- Characterize beam ion confinement from NBI line #1 & #2
- Investigate the dependence of beam ion confinement on beam source, injection energy and plasma current.
- Compare with the classical theory (NUBEAM, FIDA_{sim})

Approach

- Inject short ($\sim 20\text{ms} < t_{\text{slowingdown}}$) neutral beam pulses to check neutron build-up and decay rate.
- Inject relatively long ($\sim 90\text{ms} > t_{\text{slowingdown}}$) neutral beam pulses to get stationary beam ion slowing-down distribution.
- $E_{\text{inj}}=65\text{keV}$ vs. 90keV for all six neutral beam sources;
 $I_p=0.7\text{MA}$ vs. 0.55MA at $B_t=0.65\text{T}$
- Monitor fast ion losses with sFLIP in all scenarios.

W. W. Heidbrink, Nucl. Fusion 2003



Summary

- It is important to check beam ion confinement on NSTX-U and gain confidence in utilizing the 2nd NBI as a tool to drive current, control q or pressure profile.
- A comprehensive set of fast ion diagnostics will be used to study the fast ion confinement. Diagnostics are nearly ready for experiments.
- Modelling with TRANSP and FIDA_{sim} suggests that FIDA and SSNPA profile or signal magnitude will change with neutral beam source.
- Experimental plan and data analysis tools for beam ion confinement on NSTX-U have been developed.